


<b>Search Notes</b>  	<b>Application/Control No.</b>  10573630	<b>Applicant(s)/Patent Under Reexamination</b>  OHISHI ET AL.
	<b>Examiner</b>  Nguyen, Dung V	<b>Art Unit</b>  3723

SEARCHED			
Class	Subclass	Date	Examiner
451	5	3/30/2007	DVN
451	6	3/30/2007	DVN
451	8-11	3/30/2007	DVN
451	59	3/30/2007	DVN
451	75	3/30/2007	DVN
451	92	3/30/2007	DVN
	updated	7/17/2007	DVN

SEARCH NOTES		
Search Notes	Date	Examiner
See Search History	3/30/2007	DVN
See Search History	7/17/2007	DVN

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
	See Search History	7/17/2007	DVN